

# Improving detection efficiency of Ti based superconducting transition edge sensors with optical cavity

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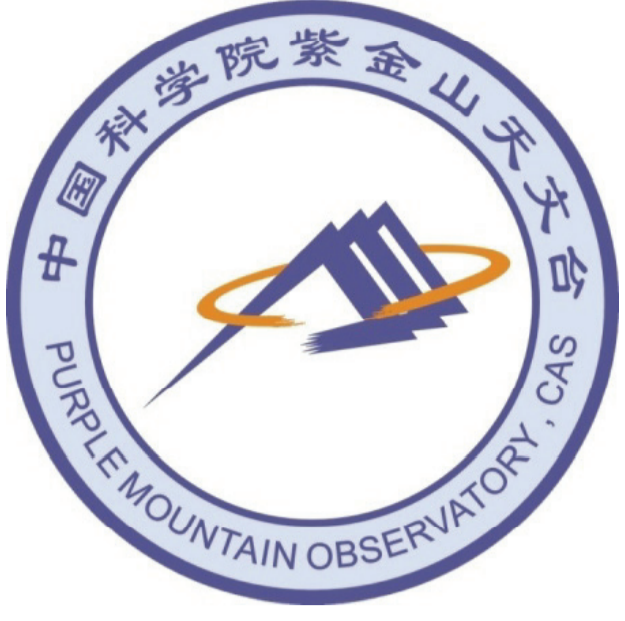
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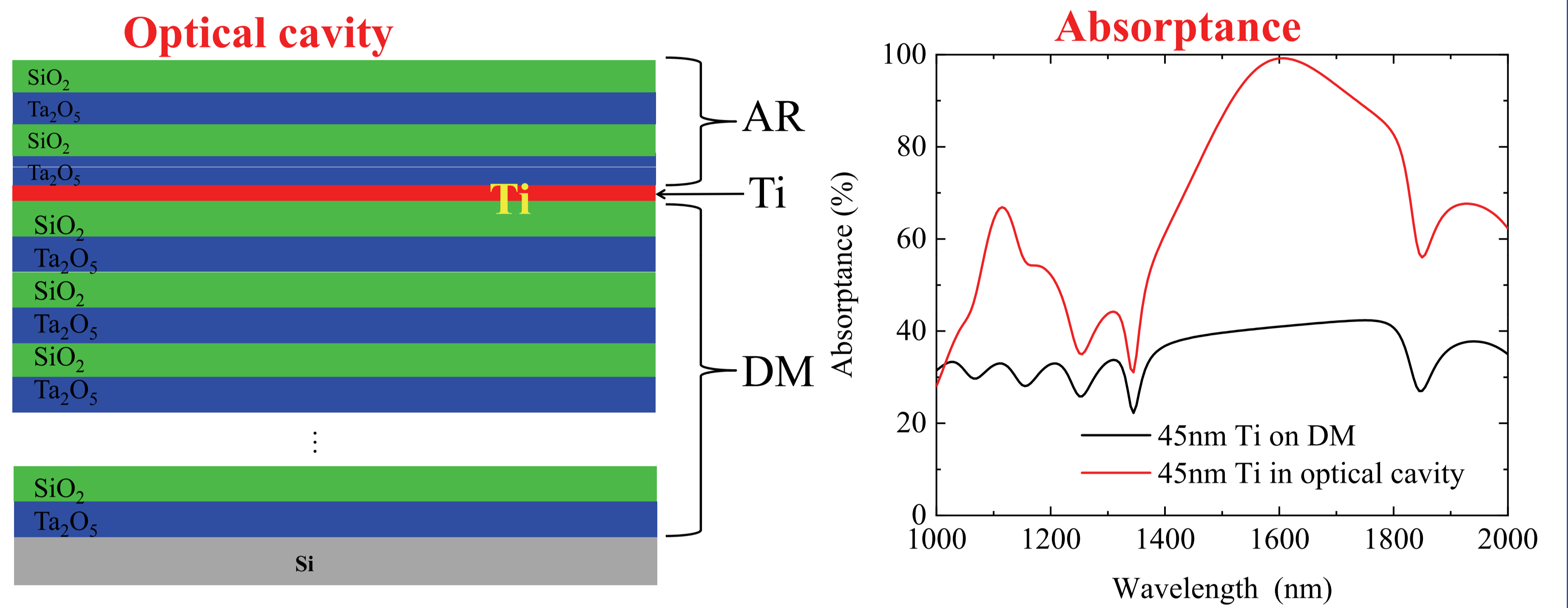
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- Superconducting transition edge sensor (TES) single photon detectors have demonstrated high quantum efficiency and photon number resolving capability. *A.E. Lita, et al., Opt. Express, 16(5), 3032, 2008*
- Furthermore, Ti-based TES is very fast (response time of ~100 ns) thanks to the high critical temperature of ~400 mK. *D. Fukuda, et al., Proc. SPIE., 7236, & 2360C, 2009*
- We have developed Ti-based TES, and studied its electrical and optical performance. *W. Zhang, et al., IEEE Trans. Appl. Supercond., 29(5), 2100505, 2019*
- Here, we present the improvement of detection efficiency of Ti-based TES embedded in an optical cavity.

## Optical cavity

- Optical cavity composed of anti-reflection coating (AR) and dielectric mirror (DM);
- AR and DM consist of 16 and 4 layers of SiO<sub>2</sub> and Ta<sub>2</sub>O<sub>5</sub>, respectively;
- Thickness for DM is fixed to 0.25 λ;
- Thickness for AR optimized with Macleod software;
- Absorptance increased by a factor of 2 by adding AR.



## Fiber alignment

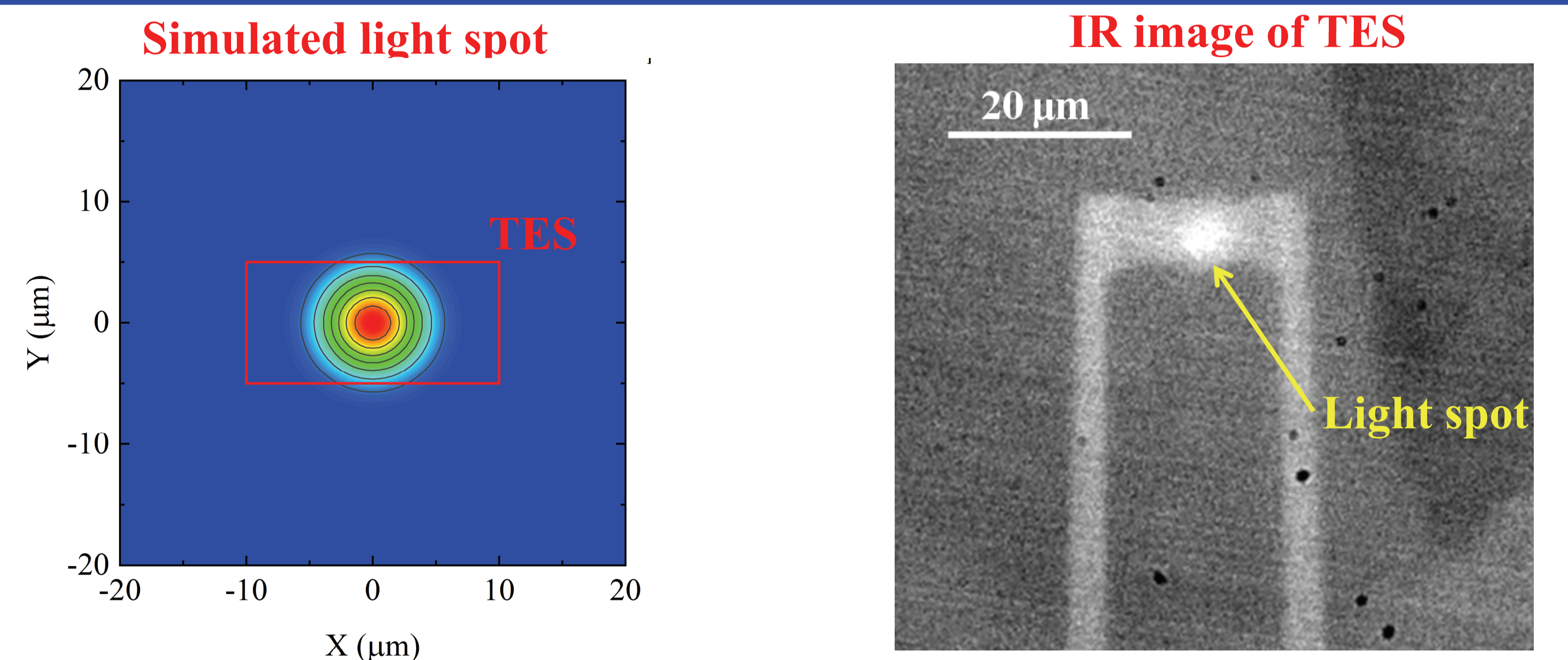
- Fiber ~20 μm far from TES;
- Light spot from the fiber is Gaussian distribution;

$$I(x, y) = \frac{2}{\pi\omega^2} e^{-\frac{2(x^2+y^2)}{\omega^2}}$$

- TES active area overlaps the light spot;

$$\eta_{coup} = \int_{-a/2}^{a/2} \int_{-b/2}^{b/2} I(x, y) dx dy$$

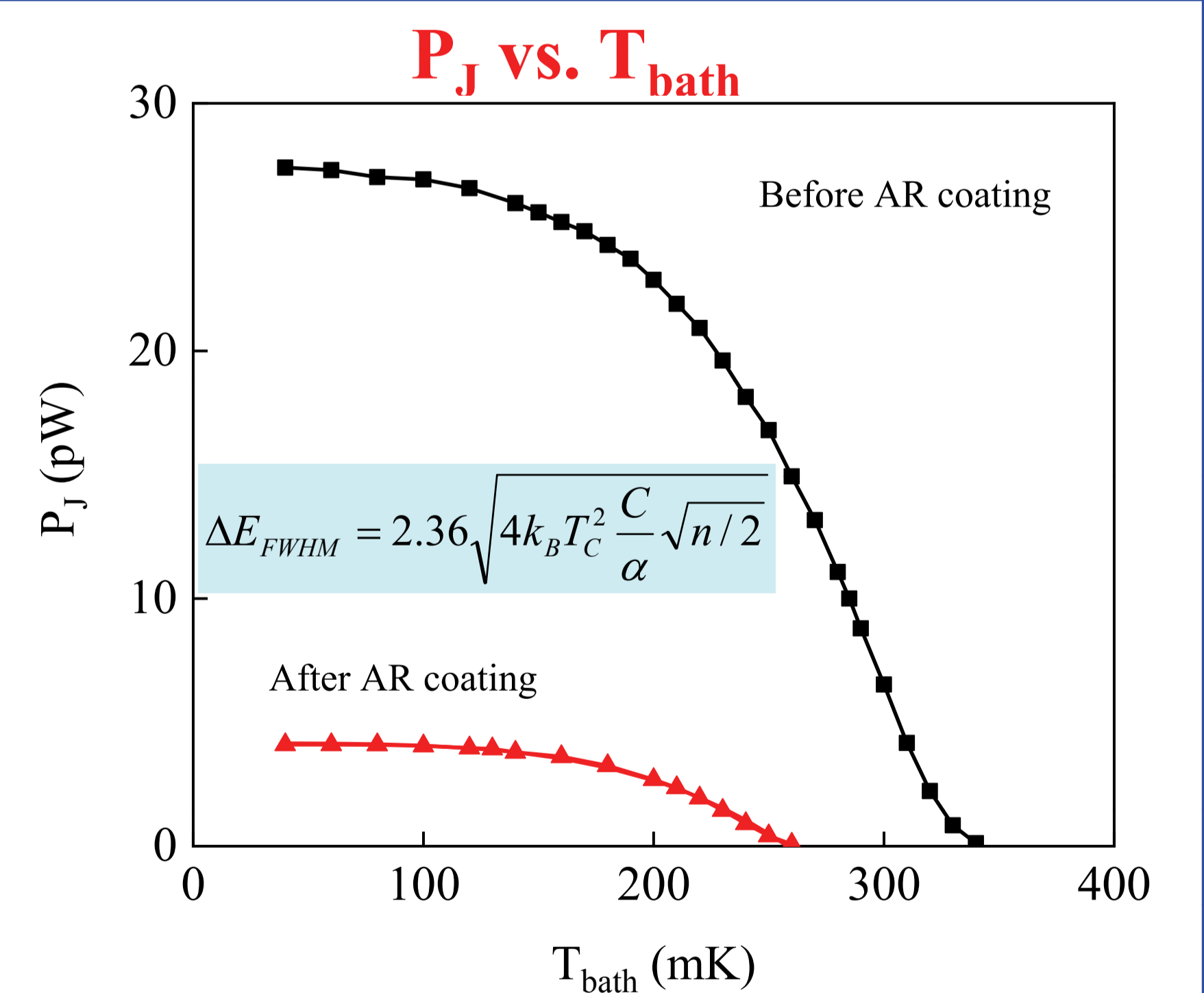
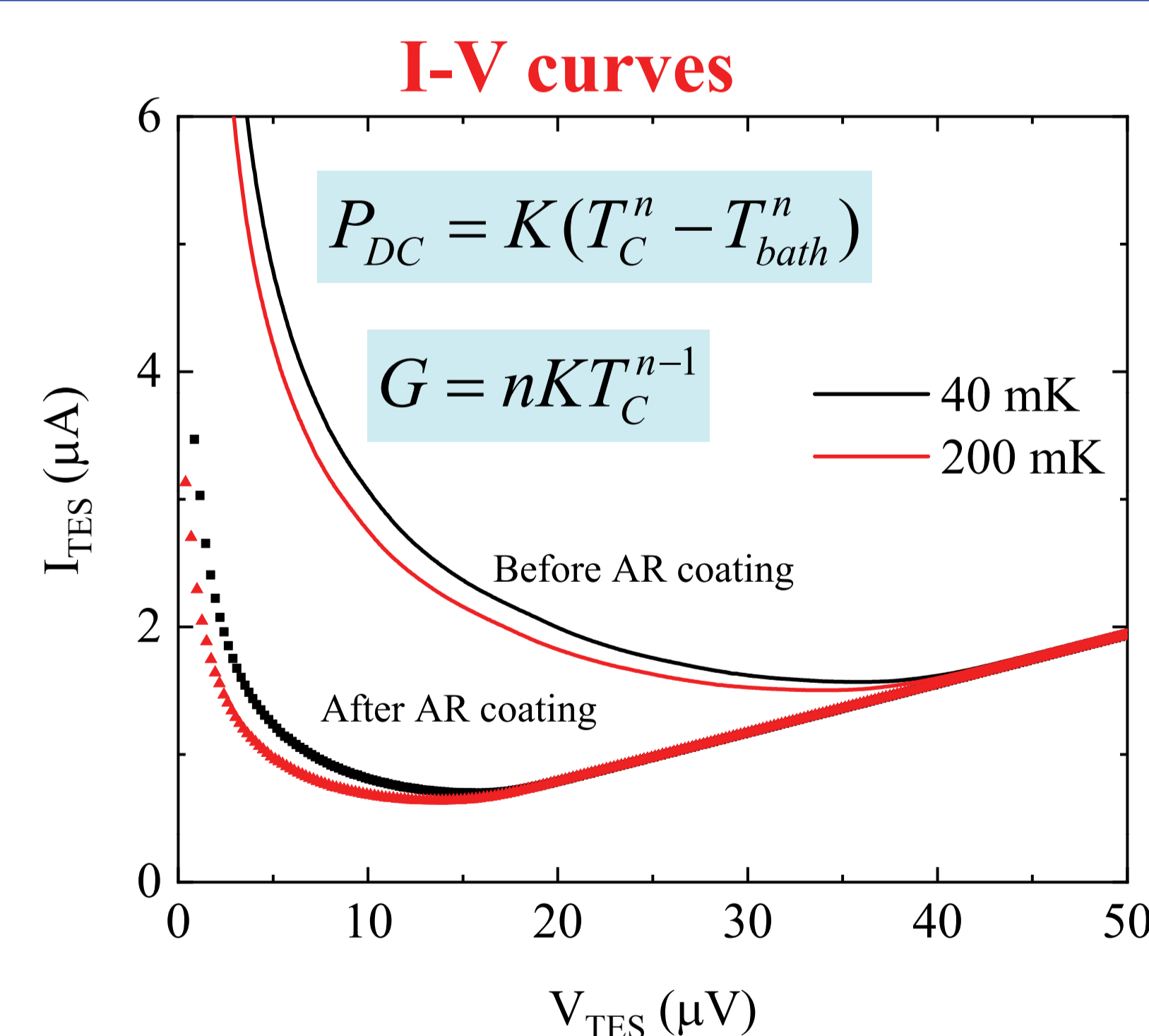
- Calculated coupling efficiency is over 90%.



## Thermal conductance

- I-V measured with SQUID readout;
- Data points chosen at a resistance of 0.7 Ω;
- G from I-V at different T<sub>bath</sub>.

	T <sub>C</sub> (K)	n	G (pW/K)	ΔE <sub>FWHM</sub> (eV)	τ <sub>eff</sub> (μs)
Before AR coating	0.323	3.7	314	0.53	1.7
After AR coating	0.258	4	64	0.35	5.9



## Detection efficiency

- Pulse response measured with a 1550 nm laser source;
- Output signal recorded by a digital oscilloscope;
- τ<sub>eff</sub> = 1.7 μs before AR coating, increased to 5.9 μs after AR coating;
- Detection efficiency is 40%, increased by a factor of 2.

